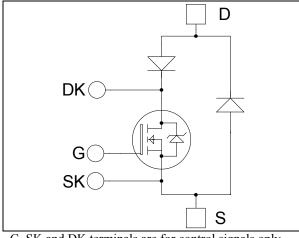
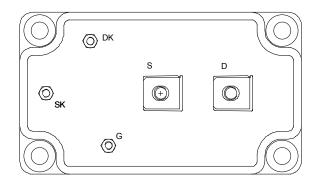


 $R_{DSon} = 65m\Omega \text{ typ}$  (a)  $Tj = 25^{\circ}C$ 

Single switch Series & SiC parallel diodes MOSFET Power Module



G, SK and DK terminals are for control signals only (not for power)



# $I_D = 145A$ @ Tc = 25°C

 $V_{DSS} = 1000V$ 

### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

### Features

### • Power MOS 7<sup>®</sup> MOSFETs

- Low R<sub>DSon</sub>
  - Low input and Miller capacitance
  - Low gate charge
  - Avalanche energy rated
  - Very rugged

### • SiC Parallel Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Kelvin source for easy drive
- Kelvin drain for voltage monitoring
- Very low stray inductance
  - Symmetrical design
  - M5 power connectors
  - M3 power connectors
- High level of integration
- AlN substrate for improved MOSFET thermal performance

### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Low profile
- RoHS Compliant

### All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V <sub>DSS</sub>	Drain - Source Voltage		1000	V
т	L <sub>p</sub> Confinuous Drain Current	$T_c = 25^{\circ}C$	145	
ID		$T_c = 80^{\circ}C$	110	А
I <sub>DM</sub>	Pulsed Drain current		580	
V <sub>GS</sub>	Gate - Source Voltage		±30	V
R <sub>DSon</sub>	Drain - Source ON Resistance		78	mΩ
P <sub>D</sub>	Power Dissipation	3250	W	
I <sub>AR</sub>	Avalanche current (repetitive and non repetitive)		30	Α
E <sub>AR</sub>	Repetitive Avalanche Energy		50	mJ
E <sub>AS</sub>	Single Pulse Avalanche Energy		3200	mJ

### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions	M	in Ty	vp Max	Unit
т	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 1000V$ $T_j = 2$	25°C		400	μA
I <sub>DSS</sub>		$V_{GS} = 0V, V_{DS} = 800V$ $T_j = 2$	125°C		2	mA
R <sub>DS(on)</sub>	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 72.5A$		6	5 78	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 20 \text{mA}$		3	5	V
I <sub>GSS</sub>	Gate – Source Leakage Current	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$			±400	nA

### **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
C <sub>iss</sub>	Input Capacitance	$V_{GS} = 0V$		28.5		
C <sub>oss</sub>	Output Capacitance	$V_{\rm DS} = 25 V$		5.08		nF
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1MHz		0.9		
Qg	Total gate Charge	$V_{GS} = 10V$		1068		
$Q_{gs}$	Gate – Source Charge	$V_{Bus} = 500V$		136		nC
$Q_{gd}$	Gate – Drain Charge	$I_{\rm D} = 145 {\rm A}$		692		
T <sub>d(on)</sub>	Turn-on Delay Time	$V_{GS} = 15V$		18		
T <sub>r</sub>	Rise Time	$V_{Bus} = 670V$		14		
T <sub>d(off)</sub>	Turn-off Delay Time	$I_D = 145A$		140		ns
$T_{\mathrm{f}}$	Fall Time	$R_G = 0.75\Omega$		55		
Eon	Turn-on Switching Energy	<b>Inductive switching</b> (a) 25°C $V_{GS} = 15V, V_{Bus} = 670V$ $I_D = 145A, R_G = 0.75\Omega$		2.9		T.
$\mathrm{E}_{\mathrm{off}}$	Turn-off Switching Energy			2.9		mJ
Eon	Turn-on Switching Energy	Inductive switching @ 125°C $V_{GS} = 15V, V_{Bus} = 670V$ $I_D = 145A, R_G = 0.75\Omega$		4.8		
$\mathrm{E}_{\mathrm{off}}$	Turn-off Switching Energy			3.9		mJ
R <sub>thJC</sub>	Junction to Case Thermal Resistance				0.038	°C/W

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### Series diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage					1000	V
I <sub>RM</sub>	Reverse Leakage Current	V <sub>R</sub> =1000V				500	μΑ
I <sub>F</sub>	DC Forward Current		$T_c = 25^{\circ}C$		240		Α
	Diode Forward Voltage	$I_{\rm F} = 240 {\rm A}$			1.9	2.5	
V <sub>F</sub>		$I_F = 480A$			2.2		V
		$I_{\rm F} = 240 {\rm A}$	$T_{j} = 125^{\circ}C$		1.7		
+	Powerse Pessevery Time	I - 240A	$T_j = 25^{\circ}C$		280		
t <sub>rr</sub>	Reverse Recovery Time		$T_{j} = 125^{\circ}C$		350		ns
Q <sub>rr</sub>	Reverse Recovery Charge	$di/dt = 800 A/\mu s$	$T_j = 25^{\circ}C$		3		μC
Чп			$T_{j} = 125^{\circ}C$		14.4		μΟ
R <sub>thJC</sub>	Junction to Case Thermal Resistance					0.23	°C/W

### SiC Parallel diode ratings and characteristics

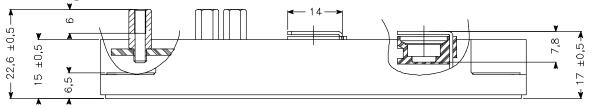
Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage					1200	V
T	D	M 1200M	$T_j = 25^{\circ}C$		384	2400	
I <sub>RM</sub>	Reverse Leakage Current	V <sub>R</sub> =1200V	$T_{j} = 175^{\circ}C$		672	12000	μA
I <sub>F</sub>	DC Forward Current		$Tc = 100^{\circ}C$		120		Α
Υ.	Diode Forward Voltage	$L_{n} = 120\Delta$	$T_i = 25^{\circ}C$		1.6	1.8	V
$V_{\rm F}$			$T_j = 175^{\circ}C$		2.3	3 3.0	
Q <sub>c</sub>	Total Capacitive Charge	$I_F = 120A, V_R = 1200V$ di/dt =5000A/µs			960		nC
G		$f = 1 MHz, V_R = 200 V$		1152			
С	Total Capacitance $f = 1 MHz, V_R = 400V$		= 400V		828		pF
R <sub>thJC</sub>	Junction to Case Thermal Resistance					0.18	°C/W

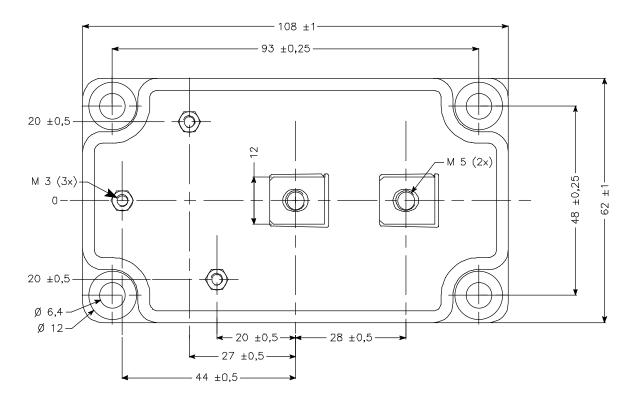
### Thermal and package characteristics

Symbol	Characteristic				Max	Unit		
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000		V		
T <sub>J</sub>	Operating junction temperature range			-40	150			
T <sub>JOP</sub>	Recommended junction temperature under	switching condition	ns	-40	T <sub>J</sub> max -25	°C		
T <sub>STG</sub>	Storage Temperature Range			-40	125	ĒŪ		
T <sub>C</sub>	Operating Case Temperature	-40	100					
	Mounting torque	To heatsink	M6	3	5			
Torque		For terminals	M5	2	3.5	N.m		
	For terminars M3				1.5			
Wt	Package Weight				300	g		



SP6 Package outline (dimensions in mm)

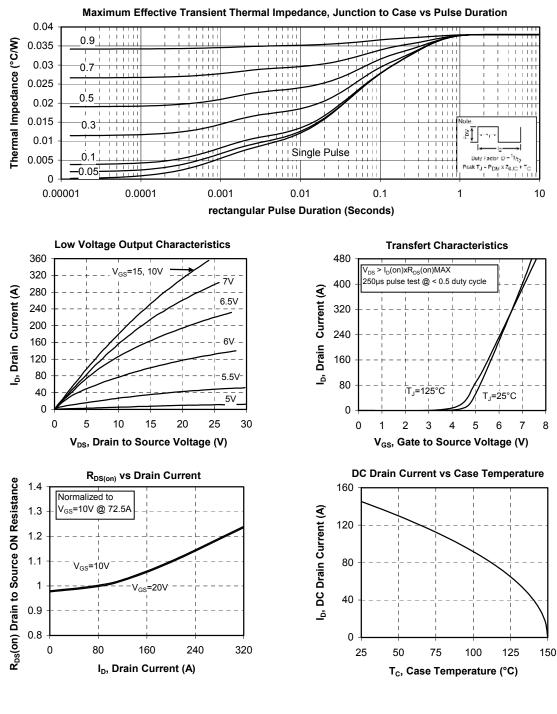




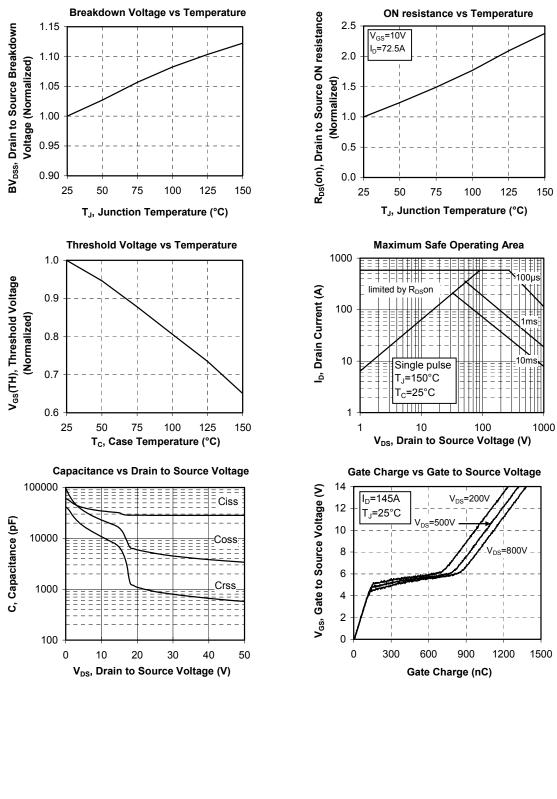
See application note APT0601 - Mounting Instructions for SP6 Power Modules on www.microsemi.com



### **Typical MOSFET Performance Curve**





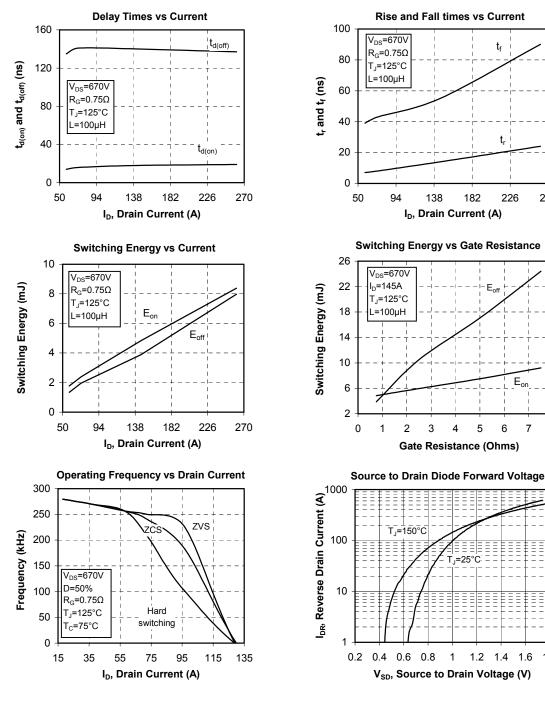




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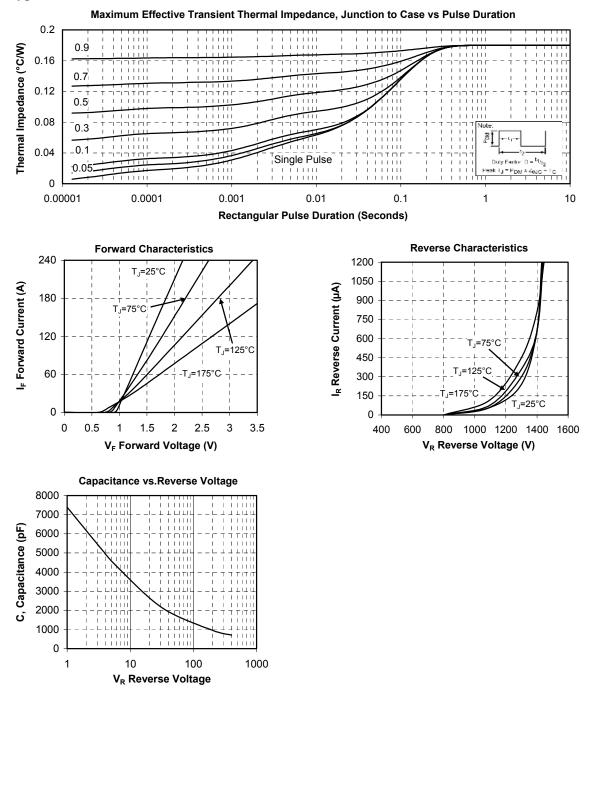
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### **Typical SiC Diode Performance Curve**



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